

Notice of References Cited	Application/Control No. 10/585,846		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner PATRICK F. RIEGLER		Art Unit 2173	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,266,768	09-2007	Ferlitsch et al.	715/273
*	B	US-2002/0091739	07-2002	Ferlitsch et al.	707/526
*	C	US-7,516,162	04-2009	Mochizuki, Takatoshi	707/200
*	D	US-7,454,763	11-2008	Veselova et al.	719/329
*	E	US-7,409,644	08-2008	Moore et al.	715/774
*	F	US-7,162,488	01-2007	DeVorchik et al.	707/102
*	G	US-6,466,237	10-2002	Miyao et al.	715/838
*	H	US-7,240,291	07-2007	Card et al.	715/776
*	I	US-6,421,070	07-2002	Ramos et al.	715/763
*	J	US-2005/0091596	04-2005	Anthony et al.	715/712
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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